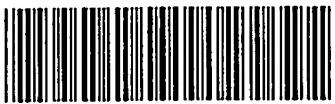


Search Notes**Application/Control No.**

10/049,287

Examiner

Edith M. Chang

Applicant(s)/Patent under Reexamination

FUJII ET AL.

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	212 219	9/27/05	eh
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340	10, 2	=	=
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439	65, 489	4/3/06	eh
	955)	=

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST PALM/edan Inventor's Name Search	9/27/05	eh
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INTERFERENCE SEARCHED

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